

SONY

CXL5005M/P

CMOS-CCD 1H Delay Line for NTSC with PLL

Description

The CXL5005M/P are general-purpose CCD delay line ICs which provide 1H delay time of NTSC.

Features

- Low power consumption 90mW (Typ.)
- Small size package (14-pin SOP, DIP)
- Low differential gain DG = 3% (Typ.)
- Input signal amplitude 180 IRE (= 1.28Vp-p, max.)
- Low input clock amplitude operation 200mVp-p (Min.)
- Built-in triple PLL circuit
- Built-in peripheral circuits (clock driver, timing generator, auto-bias and output circuits)

Functions

- 680-bit CCD register
- Clock drivers
- Autobias circuit
- Sync tip clamp circuit
- Sample-and-hold circuit
- PLL (triple)

Structure

CMOS-CCD

Absolute Maximum Ratings (Ta = 25°C)

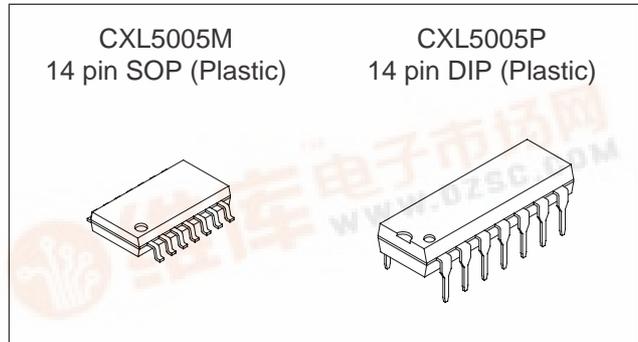
- Supply voltage V_{DD} 11 V
- Supply voltage V_{CL} 6 V
- Operating temperature Topr -10 to +60 °C
- Storage temperature Tstg -55 to +150 °C
- Allowable power dissipation P_D
 - CXL5005M 400 mW
 - CXL5005P 800 mW

Recommended Operating Conditions

- Supply voltage V_{DD} 9 ± 5% V
- V_{CL} 5 ± 5% V

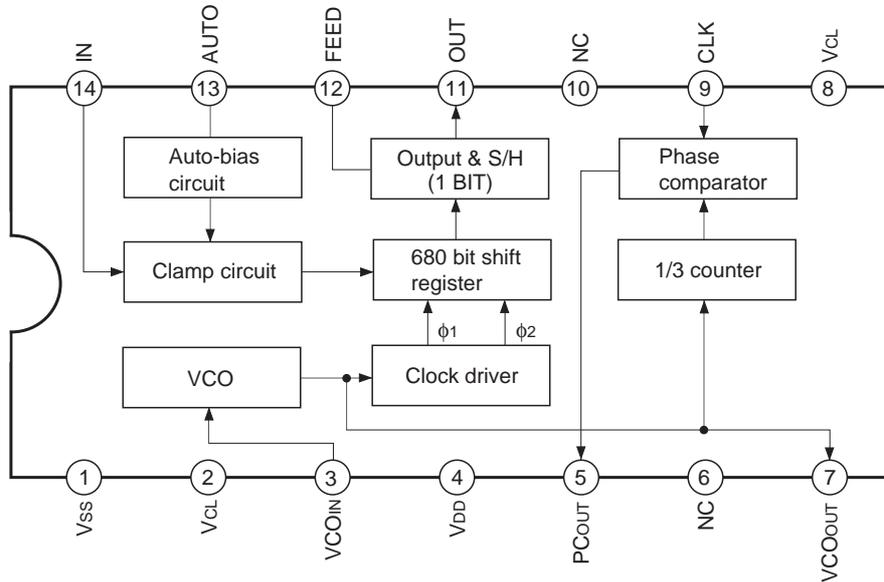
Recommended Clock Conditions

- Input clock amplitude V_{CLK} 200mVp-p to 1.0Vp-p (300mVp-p typ.)
- Clock frequency f_{CLK} 3.579545MHz



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Block Diagram and Pin configuration



Pin Description

| Pin No. | Symbol | Description | Impedance [Ω] |
|---------|--------------------|-------------------------|------------------------|
| 1 | VSS | GND | |
| 2 | VCL | 5V power supply | |
| 3 | VCO _{IN} | VCO input | > 100k |
| 4 | VDD | 9V power supply | |
| 5 | PC _{OUT} | Phase comparator output | ≈ 5k |
| 6 | NC | | |
| 7 | VCO _{OUT} | VCO output | ≈ 5k |
| 8 | VCL | 5V power supply | |
| 9 | CLK | Clock input | ≈ 5k |
| 10 | NC | | |
| 11 | OUT | Signal output | 600 to 1k |
| 12 | FEED | Feedback DC output | > 100k |
| 13 | AUTO | Autobias DC output | ≈ 10k |
| 14 | IN | Signal input | > 100k |

Electrical Characteristics

($T_a = 25^\circ\text{C}$, $V_{DD} = 9.0\text{V}$, $V_{CL} = 5.0\text{V}$, $f_{CLK} = 3.58\text{MHz}$, $V_{CLK} = 300\text{mVp-p}$ sine wave, See "Electrical Characteristics Test Circuit")

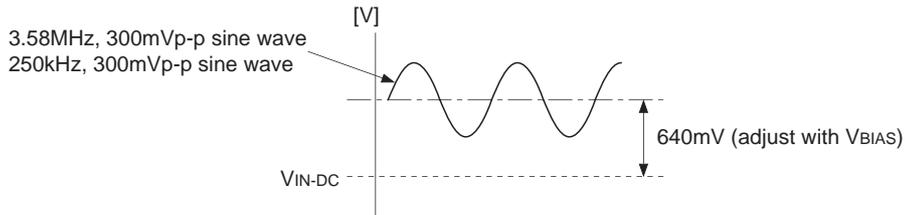
| Item | Symbol | Test condition | SW condition | | Measuring point | Min. | Typ. | Max. | Unit |
|---------------------------|----------------------|---|--------------|---|-----------------|------|------|------|------|
| | | | 1 | 2 | | | | | |
| Supply current | I _{DD} | 250kHz, 1.28Vp-p, sine wave input | a | a | A1 | — | 4.0 | 5.0 | mA |
| | I _{CL} | | | | A2 | — | 9.0 | 12.0 | mA |
| Insertion gain | IG | 250kHz, 1.28Vp-p, sine wave input IG = 20 log (Output voltage [Vp-p] / 1.28 [Vp-p]) | a | a | V1 | -3.0 | 0.0 | 3.0 | dB |
| Frequency response | fG | Dissipation at 3.58MHz in relation to 250kHz fG = 20 log (V _{3.58MHz} / V _{250kHz}) (Note 1) | b, c | b | V1 | -3.0 | -2.1 | — | dB |
| Differential gain | DG | 5-staircase wave input Y = 140 IRE (= 1.0Vp-p) Measure with vector scope (Note 2) | e | a | S | — | 3.0 | 5.0 | % |
| Differential phase | DP | | | | | — | 3.0 | 5.0 | deg |
| Allowable input amplitude | V _{IN-AC} | | — | — | — | — | — | 1.28 | Vp-p |
| Noise | S/N | S: Input = 250kHz, 1.0Vp-p output (Vp-p) | f | a | V2 | 55 | 60 | — | dB |
| | | N: Input = DC GND output (V _{rms}) | d | a | | | | | |
| DC output voltage | V _{IN-DC} | | d | a | V3 | 3.5 | 5.0 | 6.5 | V |
| | V _{AUTO-DC} | | | | V4 | 3.5 | 5.0 | 6.5 | V |
| | V _{FEED-DC} | 250kHz, 1.28Vp-p, sine wave input | a | a | V5 | 1.3 | 2.3 | 3.3 | V |
| | V _{OUT-DC} | | | | V6 | 1.7 | 2.7 | 3.7 | V |

Note 1) Frequency response test condition

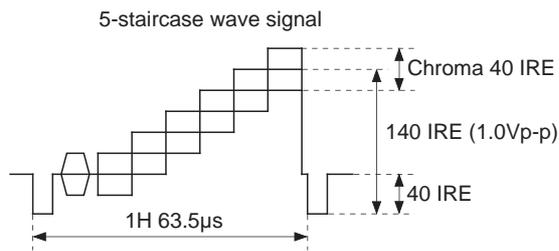
$V_{3.58\text{MHz}}$ (Output signal voltage [Vp-p] at 3.58MHz input)

$V_{250\text{kHz}}$ (Output signal voltage [Vp-p] at 250kHz input)

Set Pin 14 (IN) voltage [V] = $V_{\text{IN-DC}} + 640\text{mV}$.

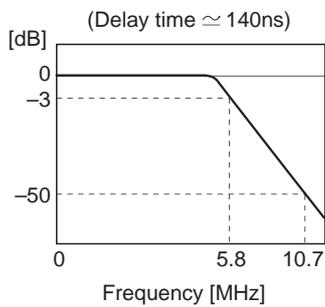


Note 2) Differential gain and differential phase test condition

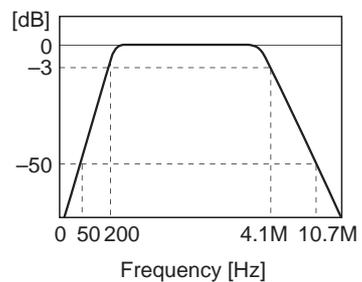


DG and DP are measured at output S point by vector scope.

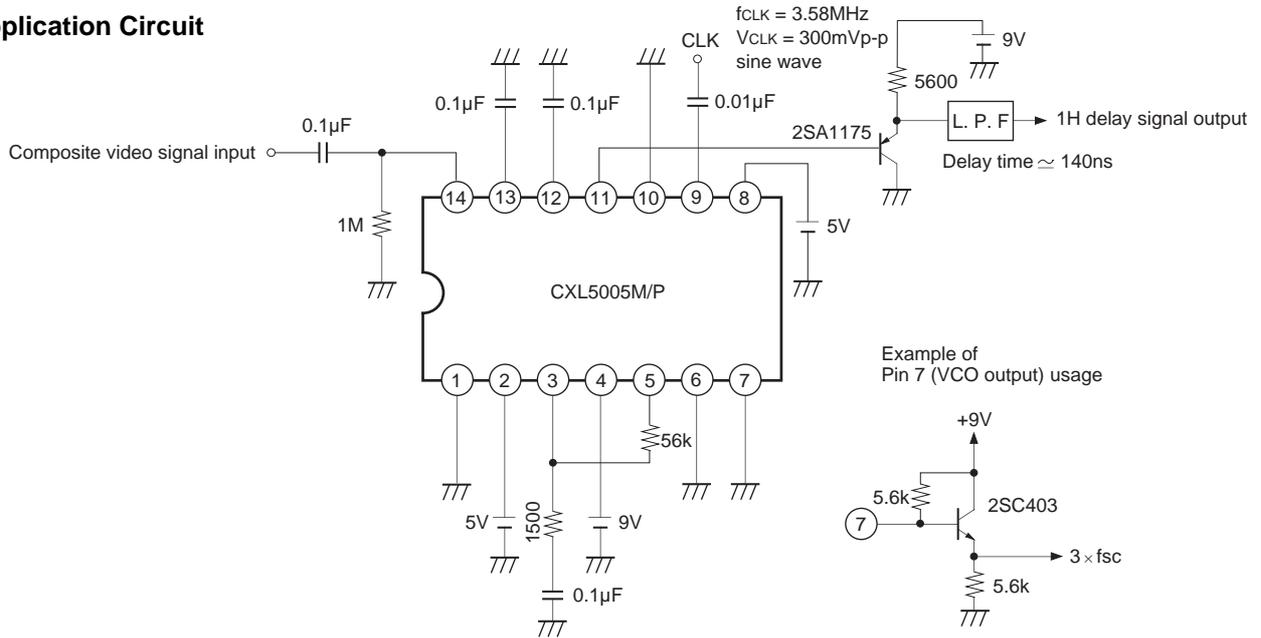
Note 3) LPF frequency response



Note 4) BPF frequency response

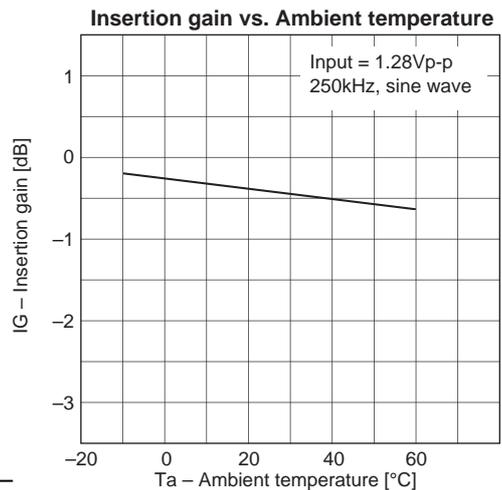
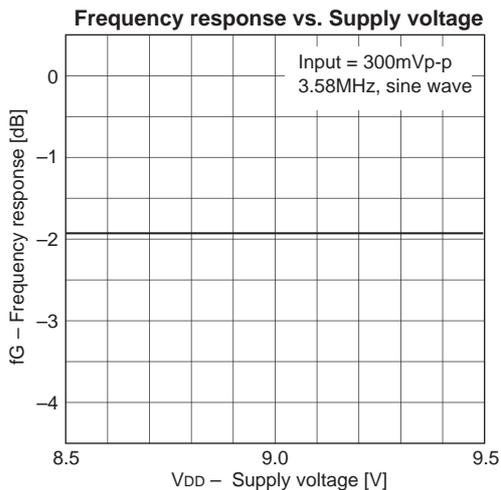
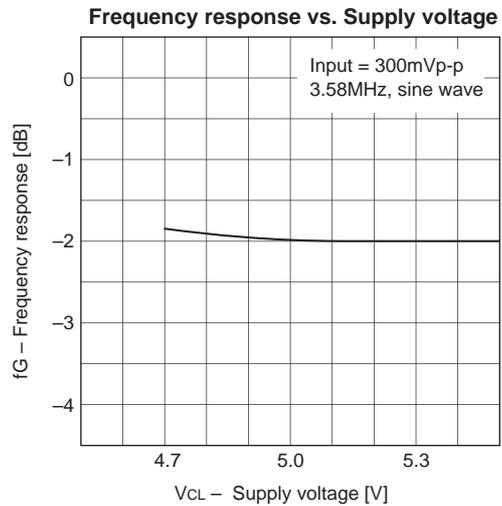
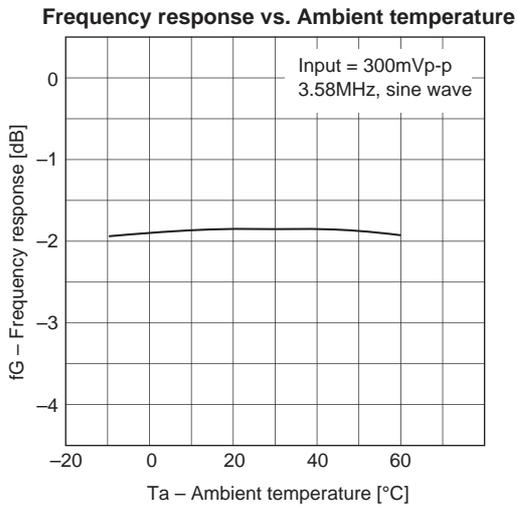


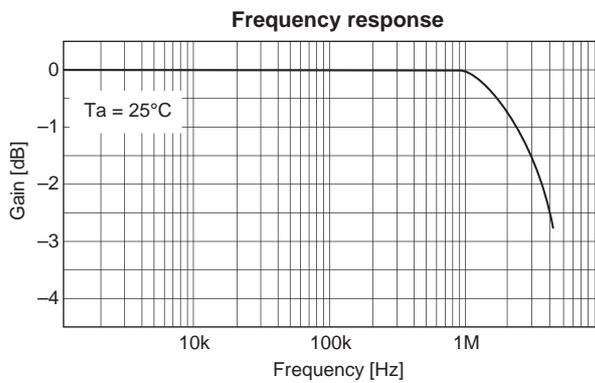
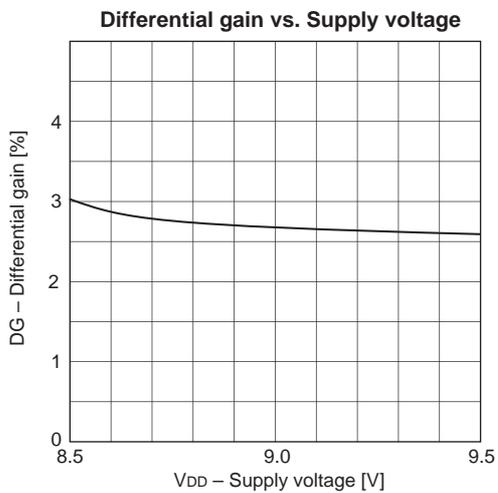
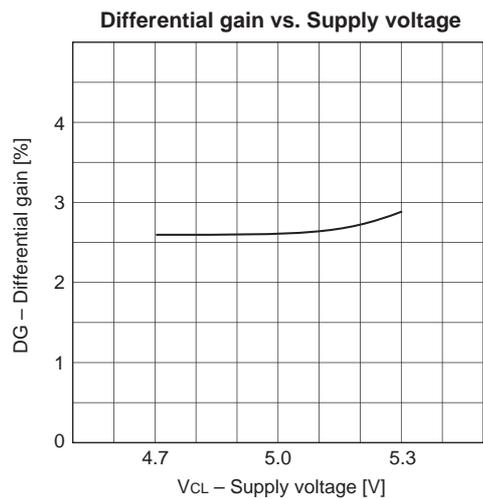
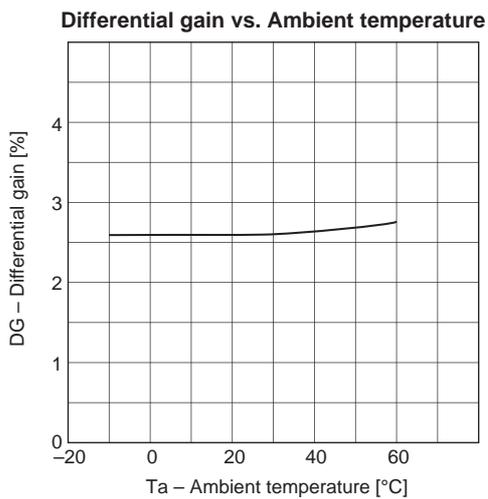
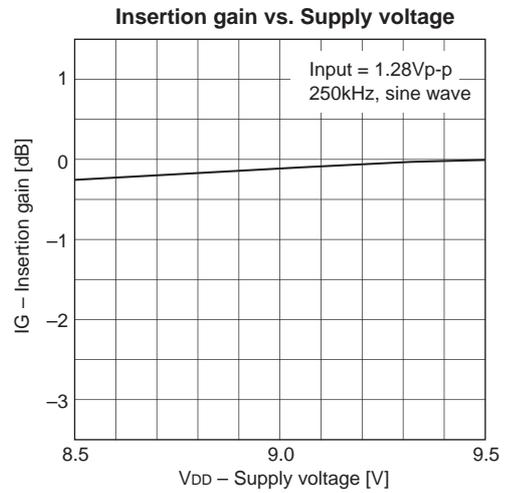
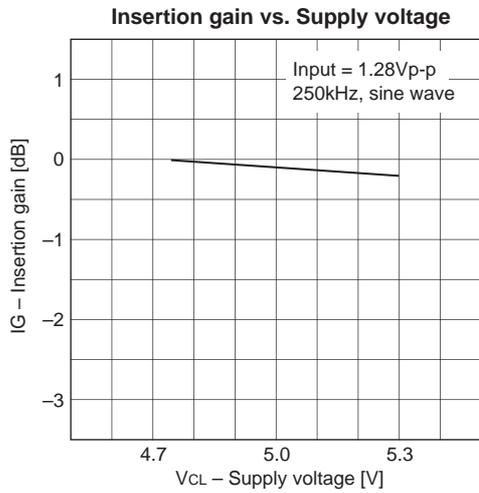
Application Circuit



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Example of Representative Characteristics

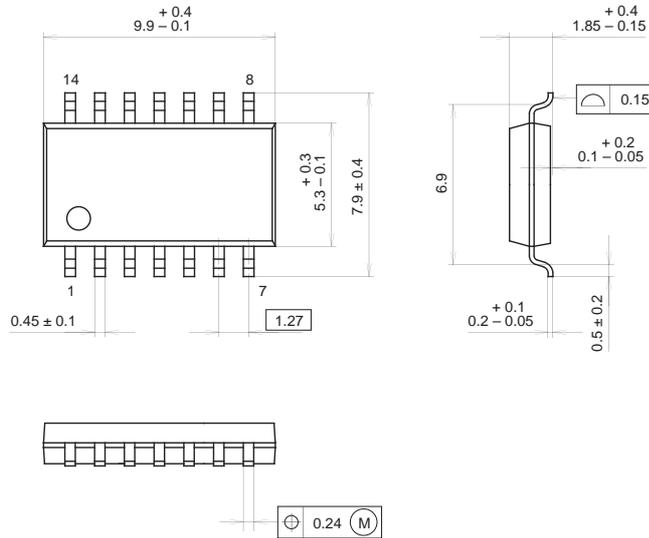




Package Outline Unit: mm

CXL5005M

14PIN SOP (PLASTIC)



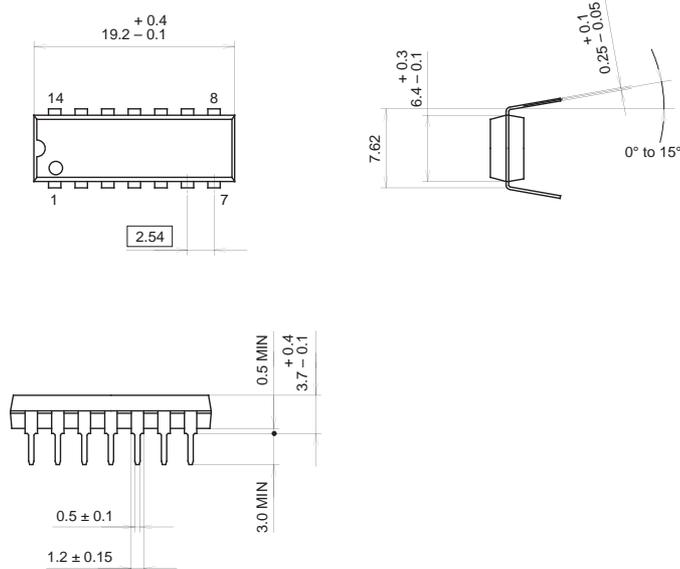
PACKAGE STRUCTURE

| | |
|------------|---------------|
| SONY CODE | SOP-14P-L01 |
| EIAJ CODE | SOP014-P-0300 |
| JEDEC CODE | |

| | |
|------------------|-----------------|
| PACKAGE MATERIAL | EPOXY RESIN |
| LEAD TREATMENT | SOLDER PLATING |
| LEAD MATERIAL | 42/COPPER ALLOY |
| PACKAGE MASS | 0.2g |

CXL5005P

14PIN DIP (PLASTIC)



PACKAGE STRUCTURE

| | |
|------------|----------------------|
| SONY CODE | DIP-14P-01 |
| EIAJ CODE | DIP014-P-0300 |
| JEDEC CODE | Similar to MO-001-AH |

| | |
|------------------|-----------------|
| PACKAGE MATERIAL | EPOXY RESIN |
| LEAD TREATMENT | SOLDER PLATING |
| LEAD MATERIAL | 42/COPPER ALLOY |
| PACKAGE MASS | 0.9g |